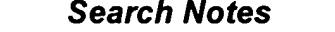


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/765,267	PAPPIN ET AL.
	Examiner Nyeemah Grazier	Art Unit 1626

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN Structure Search	3/8/2006	NG
STIC Structure and Inventor Name Search	3/10/2006	NG
Classification/Text Search (EAST) Class 544/141,172,372,399; 546/208,238)	3/11/2006	NG
IDS	3/10/2006	NG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner